

INFORMATION DISCLOSURE STATEMENT PTO-1449			ATTY. DOCKET NO. 26822-0002 C1		SERIAL NO. 10/087,527	
			APPLICANTS: RONG, Chang-Liang, et al.			
			FILING DATE: 02/28/2002		GROUP: 2873	
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
T.T.	5,177,476 *	01/05/1993	Disanto et al.	—	—	—
TT	5,872,552 *	02/16/1999	Gordon II et al.	—	—	—
TT	4,655,897 *	04/07/1987	Disanto et al.	RECEIVED SEP 09 2003 OFFICE OF PETITIONS		—
TT	3,689,346 *	09/05/1972	Rowland			—
TT	5,942,154 *	08/24/1999	Kim et al.	—	—	—
TT	3,229,607 *	01/18/1966	Battaglia	—	—	—
TT	5,877,848 *	03/02/1999	Gillette et al.	—	—	—
TT	5,731,860 *	03/24/1998	Harada et al.	—	—	—
TT	5,895,541 *	04/20/1999	Kobayashi et al.	—	—	—
TT	5,985,084 *	11/16/1999	Summersgill et al.	—	—	—
TT	3,885,964 *	05/27/1975	Nacci	—	—	—
TT	4,741,604 *	05/03/1988	Kornfeld	—	—	—
TT	5,200,120 *	04/06/1993	Sakai	—	—	—
TT	6,113,836 *	09/05/2000	Sakai et al.	—	—	—
TT	6,400,492 *	06/04/2002	Morita et al.	—	—	—
TT	6,512,626 *	01/28/2003	Schmidt	—	—	—
TT	6,514,328 *	02/04/2003	Katoh et al.	—	—	—
TT	5,589,100 *	12/31/1996	Grasso et al.	—	—	—
TT	5,835,174 *	11/10/1998	Clikeman et al.	—	—	—
TT	5,976,405 *	11/02/1999	Clikeman et al.	—	—	—
TT	6,037,05 *	03/14/2000	Clikeman et al.	—	—	—
TT	3,908,052 *	09/23/1975	Sanders	—	—	—
TT	5,274,481 *	12/28/1993	Kim	—	—	—
TT	5,739,889 *	04/14/1998	Yamada et al.	—	—	—
TT	6,120,946 *	9/19/2000	Johnson et al.	—	—	—
TT	6,166,797 *	12/26/2000	Bruzzzone et al.	—	—	—
TT	5,843,333 *	12/01/1998	Hakemi	—	—	—
TT	5,460,688 *	10/24/1995	Disanto et al.	—	—	—
TT	3,892,568	07/01/1975	Ota et al.	—	—	—

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TT	6,191,250 *	02/20/2001	Aida et al.	—	—	—	
TT	4,190,352 *	02/26/1980	Bruning	—	—	—	
TT	4,924,257 *	05/08/1990	Jain	—	—	—	
TT	5,285,236 *	02/08/1994	Jain	—	—	—	
TT	5,652,645 *	07/29/1997	Jain	—	—	—	
TT	5,398,041 *	03/14/1995	Hyatt	—	—	—	
TT	5,432,526 *	07/11/1995	Hyatt	—	—	—	
TT	5,995,190 *	11/30/1999	Nagae et al.	—	—	—	
TT	5,956,112 *	09/21/1999	Fujimori et al.	—	—	—	
TT	5,450,220 *	09/12/1995	Onishi et al.	—	—	—	
TT	6,018,383 *	01/25/2000	Dunn et al.	—	—	—	
TT	2001/0009352 *	07/26/2001	Moore	—	—	—	
TT	2002/0029969 *	03/14/2002	Yager et al.	—	—	—	
TT	2002/0196525 *	12/26/2002	Chen et al.	—	—	—	
TT	2002/0018043 *	02/14/2002	Nakanishi	—	—	—	
TT	2002/0188053 *	12/12/2002	Zang et al.	—	—	—	
TT	20020126249 *	12/05/2002	Chan-Park, et al.	—	—	—	
TT	20020126249 *	09/12/2002	Liang, et al.	—	—	—	
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EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY (Inventor)	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
TT	199 27 359.6 *	Pub. Date 12/21/00	Germany ¹ (Schmidt, F. G.)	—	—	<input type="checkbox"/>	<input checked="" type="checkbox"/>
TT	2,340,68 *	Nat'l Entry Dt 2/14/2001	Canada (Schmidt, F. G.)	—	—	<input checked="" type="checkbox"/>	<input type="checkbox"/>
TT	EP 1065553 *	Pub Date 01/03/2001	Europe (Ogawa)	—	—	<input type="checkbox"/>	<input type="checkbox"/>
TT	EP 0990942 *	Pub Date 04/05/2000	Europe (Yamanaka)	—	—	<input type="checkbox"/>	<input type="checkbox"/>
TT	EP 1195603 *	Pub Date 04/10/2002	Europe (Kawai)	—	—	<input type="checkbox"/>	<input type="checkbox"/>
TT	JP 6242423 *	Pub Date 09/02/1994	Japan (Nakai Yuichi) (English abstract included)	—	—	<input type="checkbox"/>	<input checked="" type="checkbox"/>

¹ See English counterparts US Patent No. 6,512,626 or Canadian Patent Application No. 2,340,683. Applicant would be happy to obtain a direct translation of the document if desired.

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EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY (Inventor)	CLASS	SUBCLASS	TRANSLATION
TJ	JP 1-86116 *	Pub Date 01/26/1990	Japan (Seiichiro) (English abstract included)	—	—	<input type="checkbox"/> <input checked="" type="checkbox"/>
TJ	JP 60-205452 *	Pub Date 10/17/1985	Japan (Hisanori) (English abstract included)	RECEIVED SEP 09 2003 OFFICE OF PETITIONS		<input type="checkbox"/> <input checked="" type="checkbox"/>
TJ	JP 2000 035677 *	Pub Date 02/02/2000	Japan (English abstract included)			<input type="checkbox"/> <input checked="" type="checkbox"/>
TJ	JP 2000 075497 *	Pub Date 03/14/2000	Japan (English abstract included)	—	—	<input type="checkbox"/> <input checked="" type="checkbox"/>
TJ	JP 2001 042118 *	Pub Date 02/16/2001	Japan (English abstract included)	—	—	<input type="checkbox"/> <input checked="" type="checkbox"/>
TJ	JP 2001 056653 *	Pub Date 02/27/2001	Japan (Hayakawa) (English abstract included)	—	—	<input type="checkbox"/> <input checked="" type="checkbox"/>
TJ	JP 02284126 *	Pub Date 11/21/1990	Japan (Oshiro) (English abstract included)	—	—	<input type="checkbox"/> <input checked="" type="checkbox"/>
TJ	WO 97/04398 *	Pub Date 02/06/1997	PCT (Jacobson)	—	—	<input type="checkbox"/> <input type="checkbox"/>
TJ	WO 00/77571 *	Pub Date 12/21/00	PCT ¹ (Schmidt, F. G.)	—	—	<input type="checkbox"/> <input checked="" type="checkbox"/>
TJ	WO 01/67170 *	Pub Date 09/13/2001	PCT (Liang et al.)	—	—	<input type="checkbox"/> <input type="checkbox"/>
TJ	WO 99/08151 *	Pub Date 02/18/1999	PCT (Bruzzzone et al.)	—	—	<input type="checkbox"/> <input type="checkbox"/>
TJ	WO 00/03291 *	Pub Date 01/20/2000	PCT (Jacobson et al.)	—	—	<input type="checkbox"/> <input type="checkbox"/>
TJ	WO 02/01281 *	Pub Date 01/03/2002	PCT (Liang et al.)	—	—	<input type="checkbox"/> <input type="checkbox"/>
TJ	WO 99/53373 *	Pub Date 10/21/1999	PCT (Drzaic)	—	—	<input type="checkbox"/> <input type="checkbox"/>
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	* Singer, B. "X-Y Addressable Electrophoretic Display", Proc. SID-18 (3/4): 255-266 (1977)					
	* Kazlas, P. et al., "SVGA Microencapsulated Electrophoretic Active Matrix Display for Information Appliances" <i>SID 01 Digest</i> 152-155 (2001)					
	* Bryning et al., "Reverse-Emulsion Electrophoretic Display (REED)" <i>SID 98 Digest</i> 1018-1021 (1998)					
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	* Inoue, S. et al., "High Resolution Microencapsulated Electrophoretic Display (EPD) Driven by Poly-Si TFTs With Four-Level Grayscale" <i>IEEE Transactions on Electron Devices</i> 49(8):1532-1539 (2002)					
	* Matsuda Y. "Newly designed, high resolution, active matrix addressing in plane EPD" <i>IDW 02 EP2-3</i> 1341-1344 (2002)					

¹See English counterparts US Patent No. 6,512,626 or Canadian Patent Application No. 2,340,683. Applicant would be happy to obtain a direct translation of the document if desired.

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TT	* Ota et al., "Developments in Electrophoretic Displays" <i>Proc. of SID</i> 18:243-254 (1977)	
TT	* Kishi, E et al, "5.1 Development of In-Plane EPD", Canon Research Center, SID Digest, 2000, pp 24-27	
TT	USSN 09/606,654, "Manufacturing Process for Electrophoretic Display", filed 6/28/2000 (copy provided upon request)	
EXAMINER	Tuyen Tra	DATE CONSIDERED 5/5/2004

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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T.T.	2002/0182544	12/05/02	Chan-Park, et al.	_____	_____	_____	
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						YES	NO
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9/15/03